onsemi

MOSFET - Power, Single N-Channel 100 V, 12.2 mΩ, 52 A

NVMYS012N10MCL

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	100	V
Gate-to-Source Voltage	e		V _{GS}	±20	V
Continuous Drain	Steady	$T_C = 25^{\circ}C$	۱ _D	52	А
Current $R_{\theta JC}$ (Notes 1, 3)	State	T _C = 100°C		37	
Power Dissipation	Steady	$T_{C} = 25^{\circ}C$	PD	72	W
R _{θJC} (Note 1)	State	$T_{\rm C} = 100^{\circ}{\rm C}$		36	
Continuous Drain	Steady T _A = 25°C		I _D	11.6	А
Current R _{θJA} (Notes 1, 2, 3)	State	T _A = 100°C		8.2	
Power Dissipation	' Sleady C		PD	3.6	W
R _{θJA} (Notes 1, 2)	State	$T_A = 100^{\circ}C$		1.8	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	283	А
Operating Junction and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			IS	60	А
Single Pulse Drain-to-Source Avalanche Energy (I _{AS} = 2.6 A)			E _{AS}	218	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

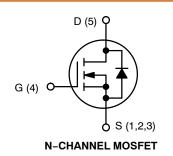
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	41.2	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
100 V	12.2 mΩ @ 10 V	52 A	
	18.3 mΩ @ 4.5 V	52 A	





ORDERING INFORMATION

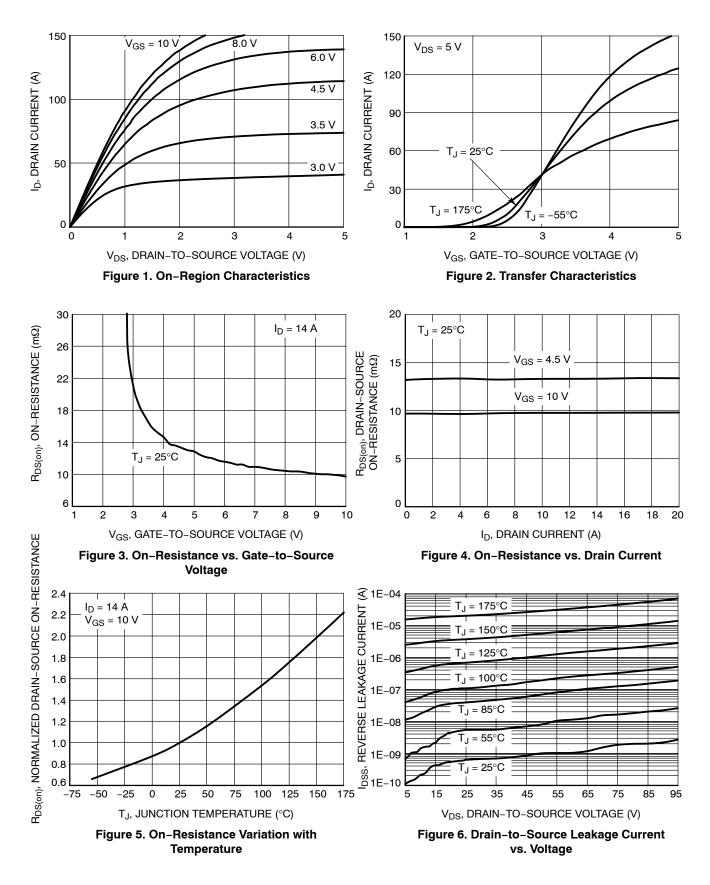
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

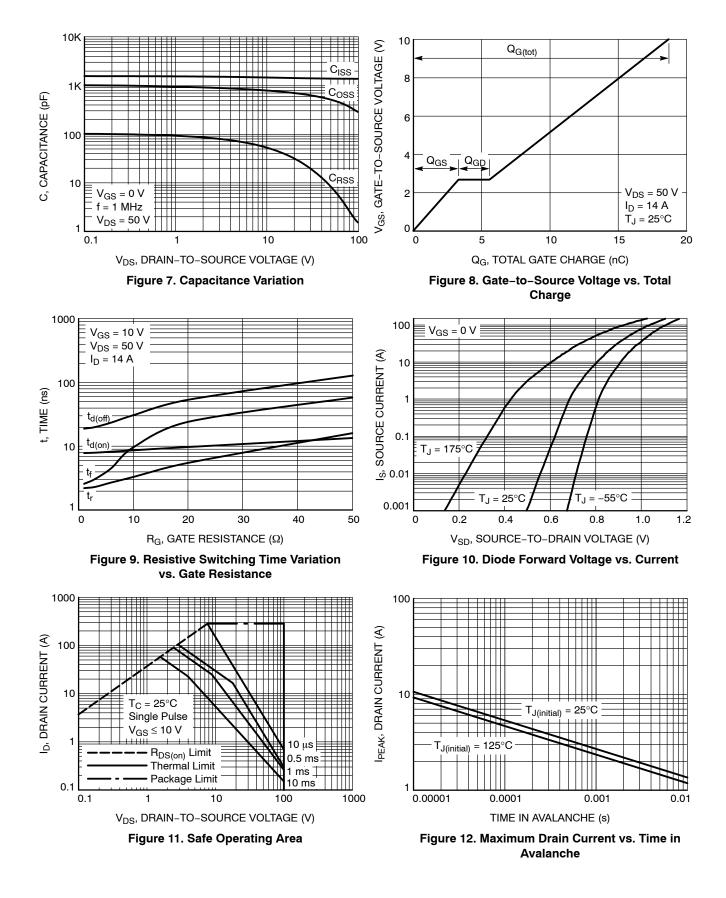
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		-					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				60		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	μΑ
	$V_{DS} = 100 V$ $T_{J} = 125^{\circ}$		T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = 20 V$				100	nA
ON CHARACTERISTICS (Note 4)		-					-
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	77 μΑ	1	1.5	3	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 14 A		9.7	12.2	mΩ
		V _{GS} = 4.5 V	I _D = 11 A		13.3	18.3	
Forward Transconductance	9 _{FS}	V _{DS} =5 V, I _D =	14 A		51		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}				1338		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz	V _{DS} = 50 V		521		1
Reverse Transfer Capacitance	C _{RSS}				9.0		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 50 V; I _D = 14 A			9.0		nC
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 50 V; I_{D} = 14 A			19		nC
Threshold Gate Charge	Q _{G(TH)}				2.0		nC
Gate-to-Source Charge	Q _{GS}	V_{GS} = 10 V, V_{DS} = 50 V; I_{D} = 14 A			3.0		
Gate-to-Drain Charge	Q _{GD}				3.0		
Plateau Voltage	V _{GP}				2.7		V
SWITCHING CHARACTERISTICS (Note	5)						
Turn-On Delay Time	t _{d(ON)}				8.4		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	= 50 V		2.7		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 14 \text{ A}, R_G = 6.0 \Omega$			23.8		
Fall Time	t _f				4.6		
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	V _{SD}		T _J = 25°C		0.79	1.3	V
<u> </u>		V _{GS} = 0 V, I _S = 14 A	T _J = 125°C		0.66		1
Reverse Recovery Time	t _{rr}	V _{GS} = 0 V, dI _S /dt = 100 A/μs, I _F = 7 A			40		ns
Reverse Recovery Charge	Q _{rr}				22		nC
Charge Time	t _a				19		ns
Discharge Time	t _b				21		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Pulse Test: pulse width ≤ 300 µs, duty cycle ≤ 2%.
5. Switching characteristics are independent of operating junction temperatures.

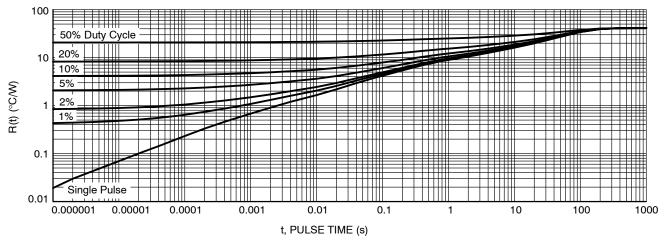
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



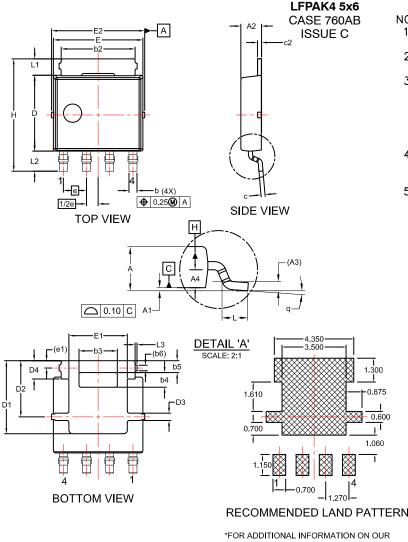


DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMYS012N10MCLTWG	012N10MCL	LFPAK4 (Pb–Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL. SOLDERRM/D.

NOTES:

- DIMENSIONING AND TOLERANCING 1. PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: 2. MILLIMETERS.
- DIMENSIONS D AND E DO NOT 3. INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE 5. DETERMINED AT DATUM PLANE H.

L	UNIT IN MILLIMETER				
DIM	MIN	NOM	MAX		
Α	1.10	1.20	1.30		
A1	0.00	0.08	0.15		
A2	1.10	1.15	1.20		
A3	().25 REF	-		
A4	0.45	0.50	0.55		
b	0.40	0.45	0.50		
b2	3.80	4.10	4.40		
b3	2.00	2.10	2.20		
b4	0.70	0.80	0.90		
b5	0.55	0.65	0.75		
b6		0.31 REI	F		
С	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
D	4.05	4.15	4.25		
D1	3.80	4.00	4.20		
D2	3.00	3.10	3.20		
D3	0.30	0.40	0.50		
D4	0.90	1.00	1.10		
Е	4.80	4.90	5.00		
E1	3.10	3.20	3.30		
E2	5.00	5.15	5.30		
е	1.27 BSC				
1/2e	0.635 BSC				
e1	0.40 REF				
Н	6.00	6.15	6.30		
L	0.40	0.65	0.85		
L1	0.80	0.90	1.00		
L2	0.90	1.10	1.30		
L3	0.00	0.10	0.20		
q	0°	4°	8°		

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